Issue Classification



_	Application/Control No.	Applicant(s)/Patent Under Reexamination							
	Application/Control No.	Applicant(5//1 atom officer Recognition							
	10647163	LOU ET AL.							
	Examiner	Art Unit							
	Hanh Nauvon	2416							
	Hanh Nguyen	2410							

ORIGINAL								INTERNATIONAL CLASSIFICATION								
CLASS SUBCLASS						CLAIMED						NON-CLAIMED				
370 208				Н	0	4	J	11 / 00 (2006.01.01)								
CROSS REFERENCE(S)					Н	0	4	В	17 / 02 (2006.01.01)							
CROSS REPERENCE(S)						Н	0	3	К	9 / 00 (2006.01.01)						
CLASS SUBCLASS (ONE SUBCLASS PER				S PER BLO	CK)											
455	134															
375	316															
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	Claims renumbered in the same order as presented by applicant								СР	'A [] T.D.	☐ R.1.47			
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1	15	17	31	33	49	49	63	65		81	23	97		
2	2	16	18	32	34	50	50	64	66		82	24	98		
3	3	17	19	33	35	51	51	65	67		83	47	99		
	4	18	20	34	36		52	66	68		84	48	100		
4	5	19	21	35	37	52	53	67	69		85	71	101		
5	6	20	22	36	38	53	54	68	70		86	72	102		
6	7	21	23	37	39	54	55	69	71		87		103		
	8	22	24	38	40		56	70	72		88		104		
7	9	25	25	39	41	55	57		73		89				
8	10	26	26	40	42	56	58		74		90				
9	11	27	27	41	43	57	59		75		91				
10	12		28	42	44	58	60		76		92				
11	13	28	29	43	45	59	61		77		93				
12	14	29	30	44	46	60	62		78		94				
13	15	30	31	45	47	61	63		79		95				
14	16		32	46	48	62	64		80		96				

NONE	Total Claims Allowed:				
(Assistant Examiner)	(Date)	72			
/Hanh Nguyen/ Primary Examiner.Art Unit 2416	8/7/09	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	1C		